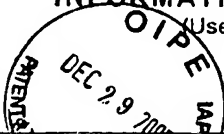


FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) 	ATTORNEY DOCKET NO.		SERIAL NO.
	9319S-000617		10/760,176
	APPLICANT		
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	FILING DATE	GROUP	
January 16, 2004	2811		

Sheet 1 of 1

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes No	
1.	SL	08-327814	12/13/1996	Japan		X	
2.	SL	09-068721 **	3/11/1997	Japan		X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	
1.	SL	Communication from Korean Patent Office re: related application.

*One or more of the English translation documents submitted herewith may be Abstracts only or partial machine created translations from the Japanese Patent Office. As such, the submitter does not necessarily vouch for their accuracy. Additional information may be obtained from the Japanese Patent Office web site at www.jpo.go.jp

** Previously cited to PTO

Examiner:	/Steven Loke/	Date Considered:	06/22/2006
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FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 1 of 1	ATTORNEY DOCKET NO.	SERIAL NO.
	9319S-000617	10/760,176
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	Reiko WACHI	
	FILING DATE	GROUP
	January 16, 2004	2811

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	SL	2002-0063834	03-12-1841	Rider		

FOREIGN PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes No
1.	SL	2002-268200	09-18-2002	Japan		X
2.	SL	08-321025	12-03-1996	Japan		X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	
1.	SL	Examination result issued in corresponding Chinese application.

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Examiner:	/Steven Loke/	Date Considered:	06/22/2006
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